A Study on the Acoustic Properties of the Constituent Films in Solidly Mounted Resonators Using Picosecond Ultrasonic Waves

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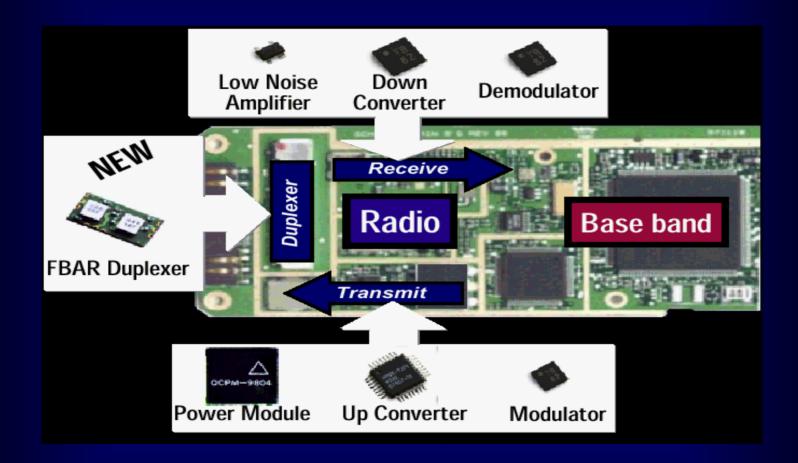
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# Outline

- Introduction
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- Algorithm

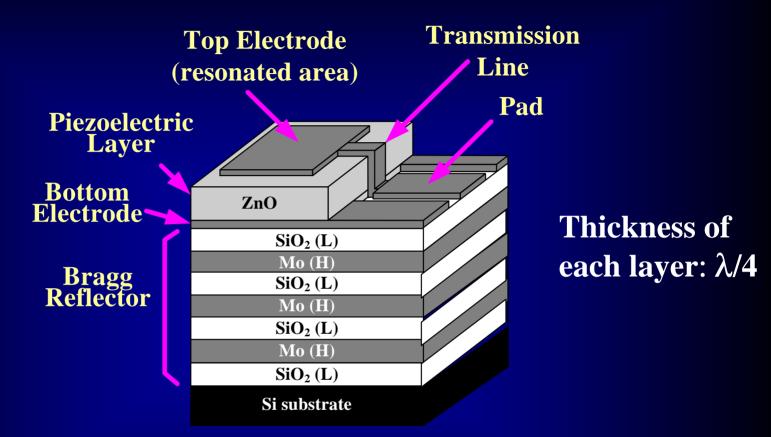
   The picosecond ultrasonic technology
- Experimental Results
  - The acoustic properties of constituent films of solidly mounted resonator
  - Thickness analysis of Bragg reflector using picosecond ultrasonics
- Conclusions

## Introduction - SoC



SoC : <u>System on a Chip</u> Picture: Agilent Technologies company

#### The SMR Structure



#### SMR(solidly mounted resonator)

Advantages:

1. Easy fabrication

2. Robust structures

3. Good power handling

Problems:

Need very accurate acoustic properties and thickness for applications at high frequency

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# Motivation

To analyze acoustic properties using high spatial resolution tool.

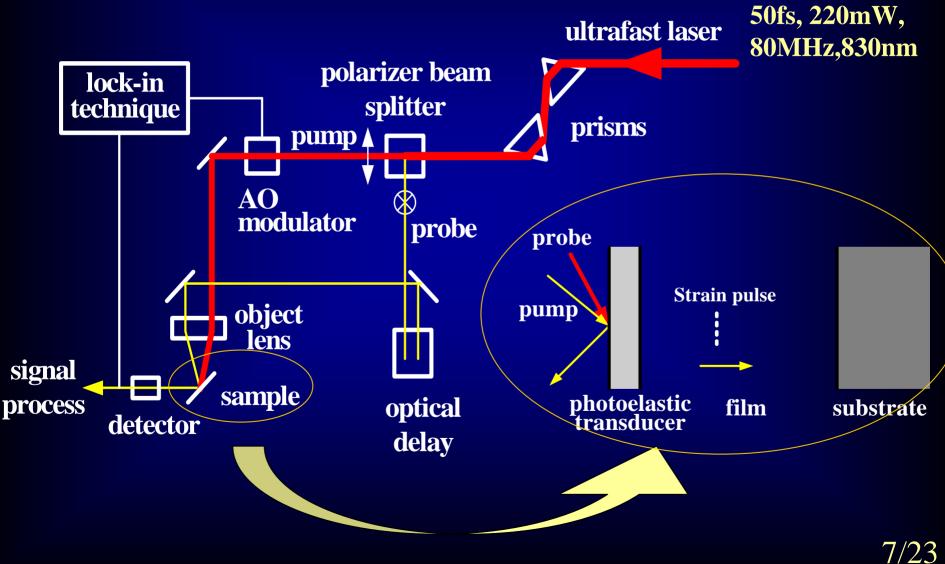
To compare differences between bulk velocity and nanofilm velocity.

To analyze thickness of the Bragg reflector using the picosecond ultrasonics

Algorithm

#### The Picosecond Ultrasonic Technology (1/4)

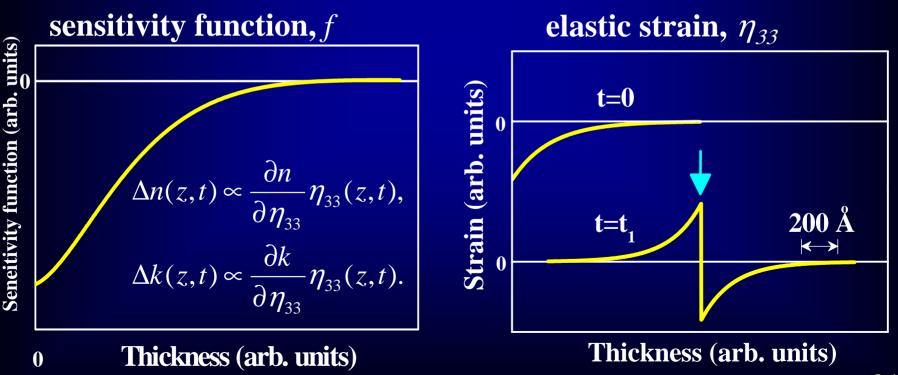
The setup



The Picosecond Ultrasonic Technology (2/4)

> The detection mechanism  $\Delta R(t) = \int_0^\infty f(z)\eta_{33}(z,t)dz$ 

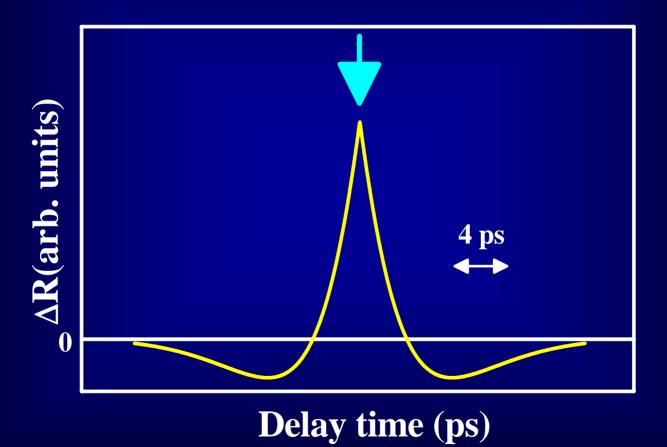
The optical reflectance changes



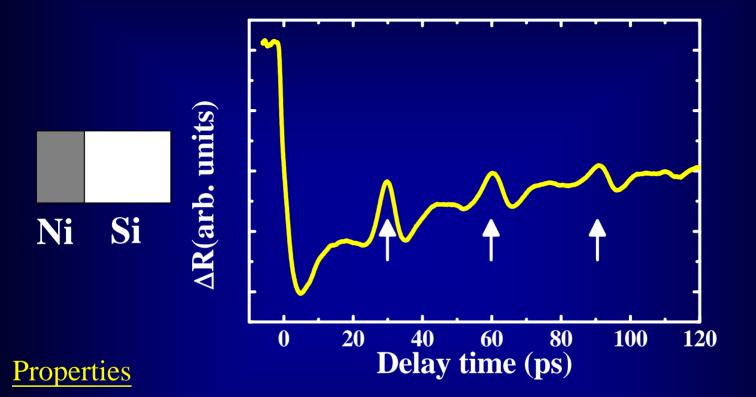
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#### The Picosecond Ultrasonic Technology (3/4)

#### Simulated echo response



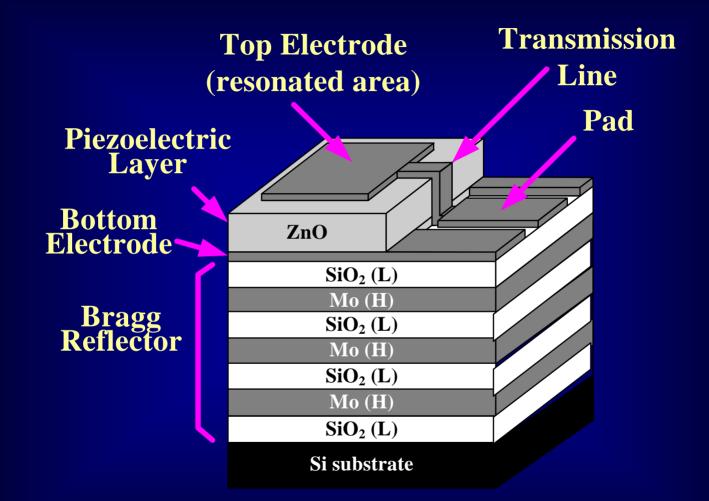
#### The Picosecond Ultrasonic Technology (4/4)



- 1. The periodic echo signals
- 2. The decreased magnitudes of the sequential signals
- 3. The broader FWHM width of the sequential signals
- 4. The peak polarity of the signal can be used to judge the difference on the acoustic impedance of the adjacent materials 10/23

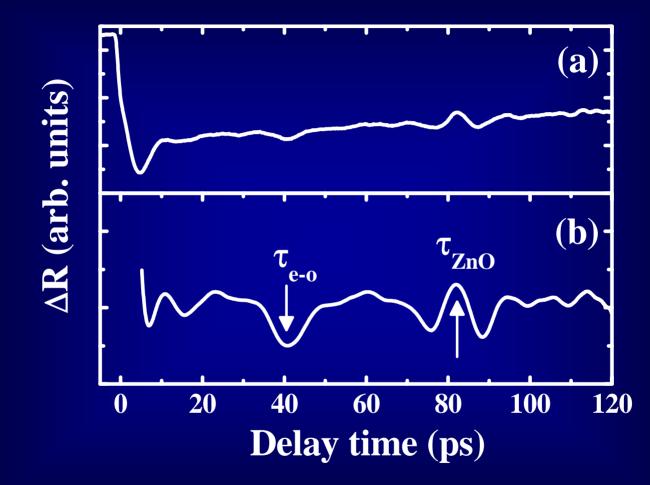
# **Experimental Results**

#### The SMR Structure



The constituent films are including ZnO, Mo, W, Ni, SiO<sub>2</sub>.

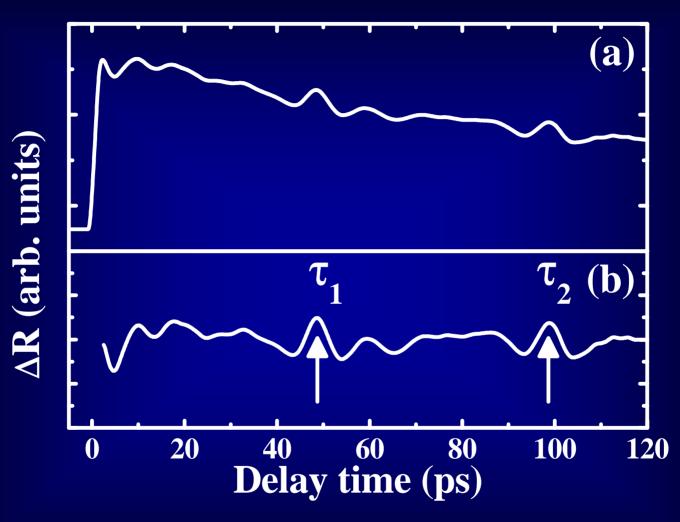
#### Constituent Films- ZnO





The velocity of ZnO nanofilm is 6560 m/s. (reference velocity: 6330 m/s)

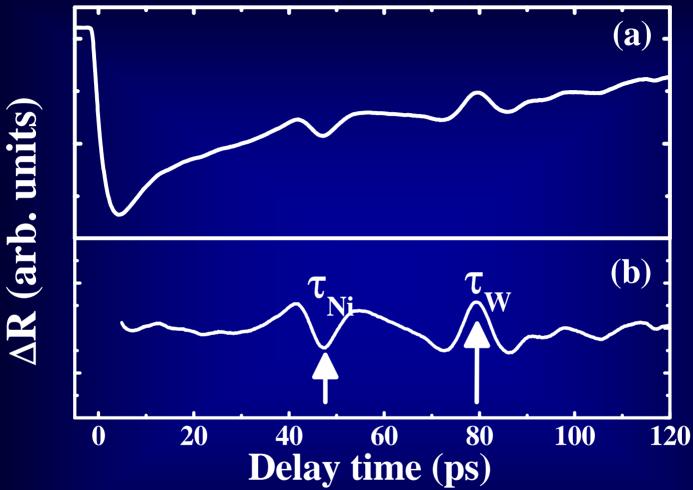
#### Constituent Films- Mo

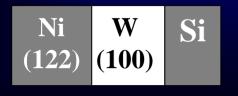




The velocity of Mo nanofilm is 7300 m/s. (reference velocity: 6430 m/s)

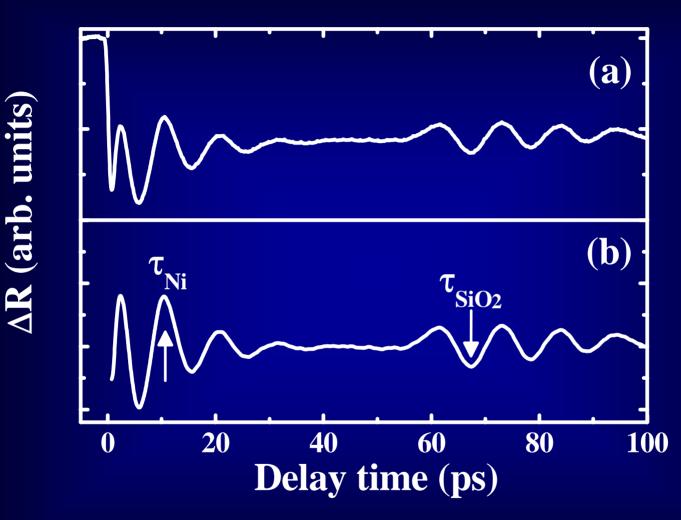
#### Constituent Films- Ni & W





The velocities of Ni and W are 5190 m/s and 6250 m/s,respectively. (reference velocities: 4970, 5230 m/s) 15/23

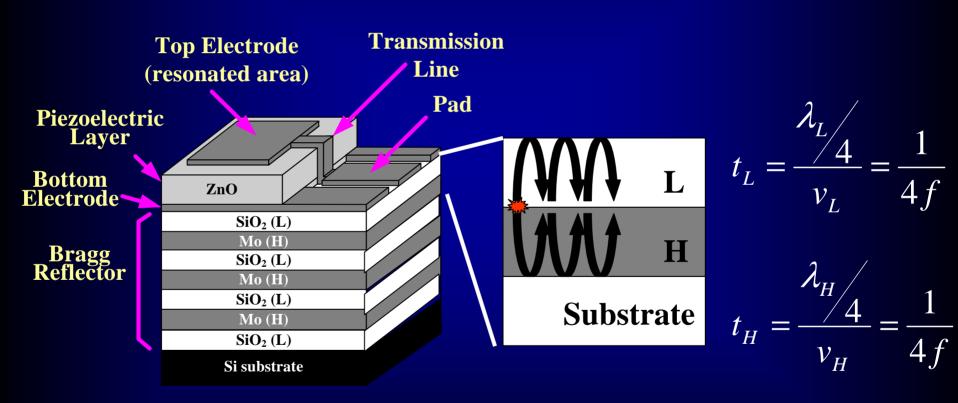
#### Constituent Films- SiO<sub>2</sub>





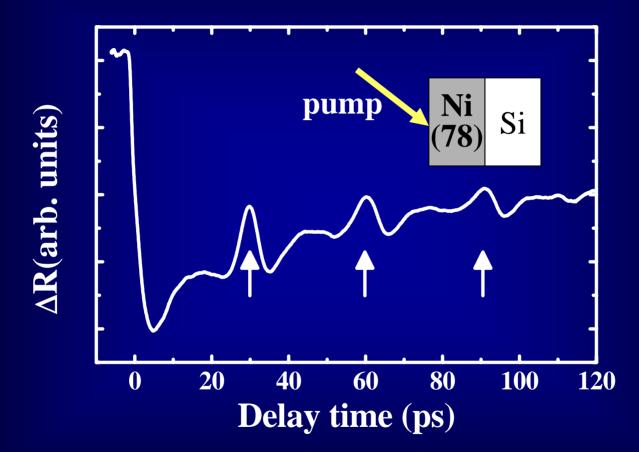
The velocity of  $SiO_2$  nanofilm is 5450 m/s. (reference velocity: 6500 m/s)

#### Thickness analysis (1/4)



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#### Thickness analysis (2/4)

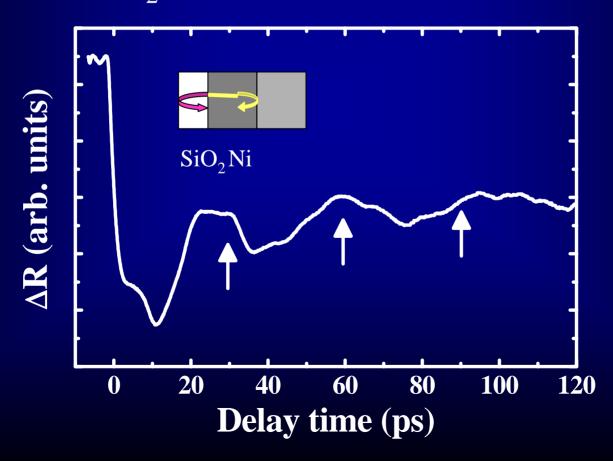


The reflectance change of the single layer of  $\lambda/4$  Bragg reflector

#### Thickness analysis (3/4)

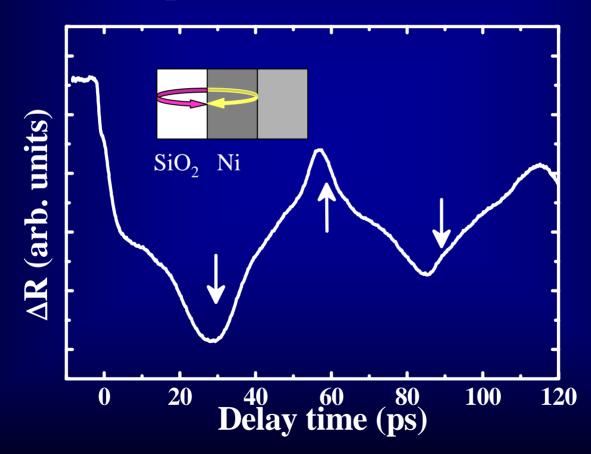
The reflectance change of double layers of Bragg reflector

SiO<sub>2</sub> thickness is smaller than  $\lambda/4$ 



#### Thickness analysis (4/4)

SiO<sub>2</sub> thickness is close to  $\lambda/4$ 



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## Conclusions

- The sound velocities of the SMR constituent nano films, including ZnO, Mo, Ni, W, SiO<sub>2</sub> etc., were measured through the picosecond ultrasonics.
- 2. The nanofilm velocity is different with the bulk velocity, and accurate velocity can be obtained by measuring

3. The accurate thickness of  $\lambda/4$  Bragg reflector can be precisely determined by matching the picosecond ultrasonic echo signals.

# Acknowledgement

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# Thanks for your attention!



